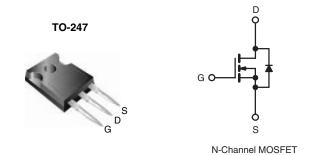


Vishay Siliconix

## **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V 0.40			
Q <sub>g</sub> (Max.) (nC)	74			
Q <sub>gs</sub> (nC)	19			
Q <sub>gd</sub> (nC)	35			
Configuration	Single			



#### **FEATURES**

- · Ultra Low Gate Charge
- · Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced Ciss, Coss, Crss
- · Isolated Central Mounting Hole
- Dynamic dV/dt Rated
- · Repetitive Avalanche Rated
- Lead (Pb)-free Available

#### **DESCRIPTION**

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.

ORDERING INFORMATION			
Package	TO-247		
Lead (Pb)-free	IRFP450LCPbF		
Lead (PD)-liee	SiHFP450LC-E3		
SnPb	IRFP450LC		
SILD	SiHFP450LC		

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage	V <sub>DS</sub>	500	V		
Gate-Source Voltage		V <sub>GS</sub>	± 30		
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}\text{C}$ $T_{C} = 100 ^{\circ}\text{C}$	I <sub>D</sub>	14	А	
Continuous Diam Current	$T_C = 100 ^{\circ}C$		8.6		
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	56	1	
Linear Derating Factor		1.5	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	760	mJ		
Repetitive Avalanche Currenta	I <sub>AR</sub>	14	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	19	mJ		
Maximum Power Dissipation	P <sub>D</sub>	190	W		
Peak Diode Recovery dV/dtc	dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
oldering Recommendations (Peak Temperature) for 10 s			300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF IVIS SCIEW		1.1	N · m	

#### **Notes**

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}=25$  V, starting  $T_J=25$  °C, L=7.0 mH,  $R_G=25$   $\Omega$ ,  $I_{AS}=14$  A (see fig. 12). c.  $I_{SD}\leq 14$  A,  $I_{AS}=14$  A,  $I_{AS}=14$  C.  $I_{SD}\leq 14$  A,  $I_{AS}=14$  A (see fig. 12).
- d. 1.6 mm from case.
- \* Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP450LC, SiHFP450LC

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static		<u>.</u>					
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0$	V, I <sub>D</sub> = 250 μA	500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	o 25 °C, I <sub>D</sub> = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	S = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		00 V, V <sub>GS</sub> = 0 V	-	-	25	μА
Drain-Source On-State Resistance		+	$I_{GS} = 0 \text{ V}, T_J = 125 \text{ °C}$	-	-	250 0.40	
	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	$I_D = 8.4 \text{ A}^b$ 0 V, $I_D = 8.4 \text{ A}^b$	0.7	-	0.40	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 5	0 V, I <sub>D</sub> = 8.4 A <sup>5</sup>	8.7		_	S
Dynamic				1	T	1	T
Input Capacitance	C <sub>iss</sub>		GS = 0 V,	-	2200	-	pF
Output Capacitance	C <sub>oss</sub>		<sub>DS</sub> = 25 V, MHz, see fig. 5	-	320	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		1 = 1.0 Wi 12, 300 lig. 3		28	-	
Total Gate Charge	$Q_g$	_	-14 A V -400 V		-	74	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 14 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	-	19	
Gate-Drain Charge	Q <sub>gd</sub>			-	-	35	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 250 V, $I_{D}$ = 14 A, $R_{G}$ = 6.2 Ω, $R_{D}$ = 17 Ω, see fig. 10 <sup>b</sup>		-	14	-	ns
Rise Time	t <sub>r</sub>			-	49	-	
Turn-Off Delay Time	$t_{d(off)}$			-	30	-	
Fall Time	t <sub>f</sub>			-	30	-	
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s			•		•	
Continuous Source-Drain Diode Current	Is	MOSFET symbol showing the integral reverse p - n junction diode		-	-	14	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	56	- A
Body Diode Voltage	$V_{SD}$	T <sub>J</sub> = 25 °C, I <sub>s</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 14 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	1.4	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05.00 !	44 A -11/-11 - 400 A / - b	-	580	870	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 14  \text{A}, dI/dt = 100  \text{A/}\mu\text{s}^b$		-	5.1	7.7	μС
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated			ninated h	v L a and	I _ \

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.



#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

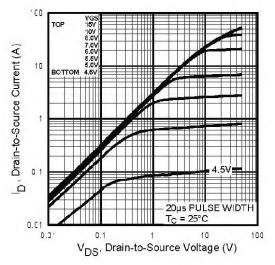


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

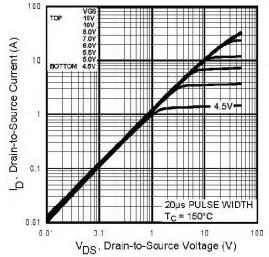


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C

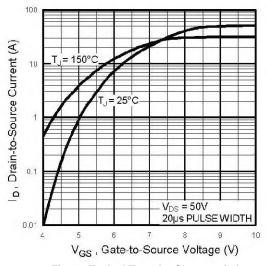


Fig. 3 - Typical Transfer Characteristics

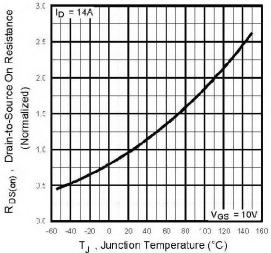


Fig. 4 - Normalized On-Resistance vs. Temperature

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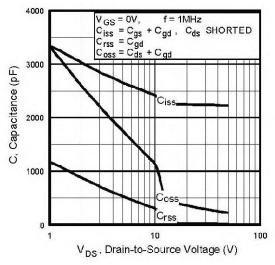


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

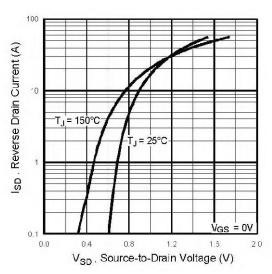


Fig. 7 - Typical Source-Drain Diode Forward Voltage

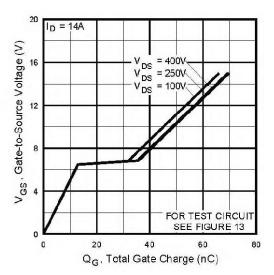


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

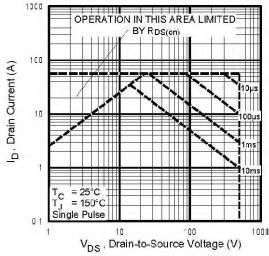


Fig. 8 - Maximum Safe Operating Area



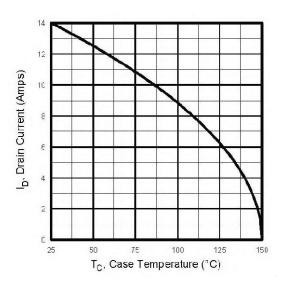


Fig. 9 - Maximum Drain Current vs. Case Temperature

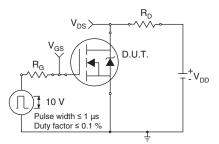


Fig. 10a - Switching Time Test Circuit

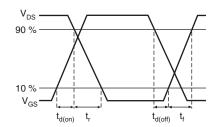


Fig. 10b - Switching Time Waveforms

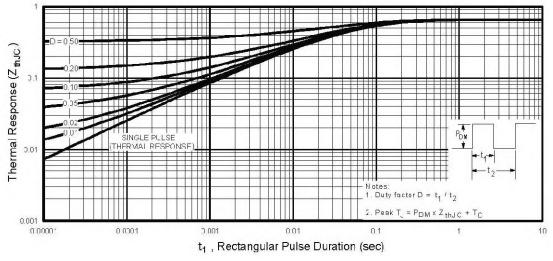


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

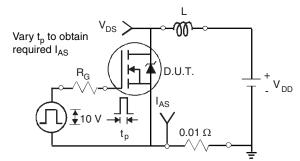


Fig. 12a - Unclamped Inductive Test Circuit

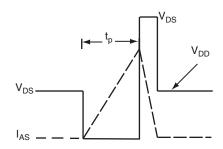


Fig. 12b - Unclamped Inductive Waveforms

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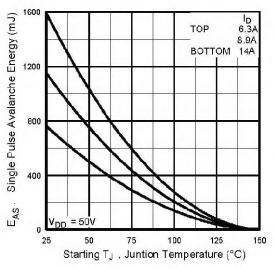


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

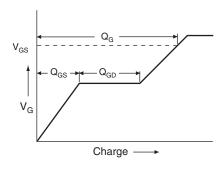


Fig. 13a - Basic Gate Charge Waveform

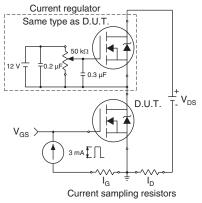
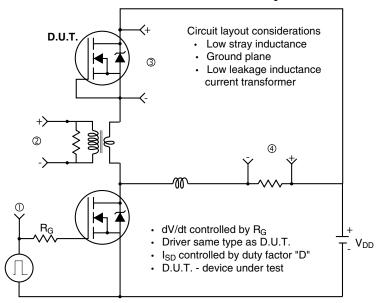
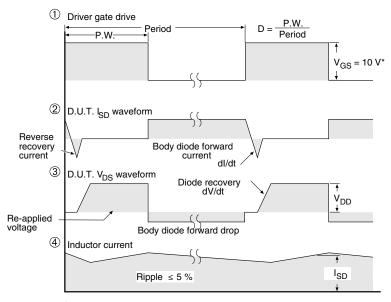


Fig. 13b - Gate Charge Test Circuit



## Peak Diode Recovery dV/dt Test Circuit





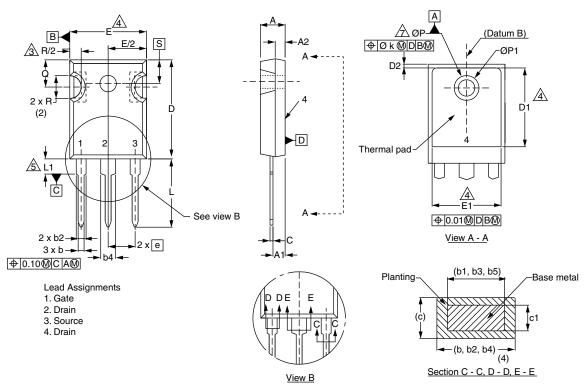
\*  $V_{GS} = 5 V$  for logic level devices

Fig. 14 - For N-Channel

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# **TO-247AC (High Voltage)**



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.58	5.31	0.180	0.209
A1	2.21	2.59	0.087	0.102
A2	1.17	2.49	0.046	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.53	2.39	0.060	0.094
b3	1.65	2.37	0.065	0.093
b4	2.42	3.43	0.095	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.82	0.776	0.820
D1	13.08	-	0.515	-

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
E	15.29	15.87	0.602	0.625	
E1	13.72	ı	0.540	ı	
е	5.46	BSC	0.215	0.215 BSC	
Øk	0.2	254	0.010		
L	14.20	16.25	0.559	0.640	
L1	3.71	4.29	0.146	0.169	
N	7.62	7.62 BSC		0.300 BSC	
ØΡ	3.51	3.66	0.138	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217 BSC		
0.217 800					

ECN: X13-0103-Rev. D, 01-Jul-13

DWG: 5971

#### **Notes**

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
  5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension c.
- 8. Xian and Mingxin actually photo.





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